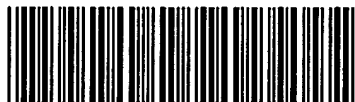


Search Notes

Application/Control No.

10/607,612

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

PUPPO ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	713	8/23/2006	BT
438	719	8/23/2006	BT
438	743	8/23/2006	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	713	8/23/2006	BT
438	719	8/23/2006	BT
438	743	8/23/2006	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	8/23/2006	BT